PATENT

Attorney Docket No.: SAM-0313

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Applic Serial Filing Title:	•	Examiner: Ng Group Art Unit G INTERCONNECTION	: 2812
below in a	CERTIFICATE OF MAILING I hereby certify that this correspondence is being deposited with the an envelope addressed to Commissioner for Patents, P.O. Box 1450	the United States Post Office as First C	Class Mail on the date indicated
	1-15-64 Date	Amy Greet	le
Comm	nissioner for Patents)	
P.O. B	3ox 1450	·	
Alexar	ndria, Virginia 22313-1450		
Sir:	SUPPLEMENTAL INFORMATIO		EMENT
	This Information Disclosure Statement is s		
[]	under 37 CFR 1.129(a), or (First/Second submission after Final Rejection)	01/22/2004 DTESSEM1 000000 01 FC:1806	086 10081661 180.00 OP
[]	under 37 CFR 1.97(b), or (Within three months of filing national application other than a CPA under §1.53(d); or within three months of date of entry of the national stage in international application; or before mailing date of first Office Action on the merits; or before mailing date of first Office Action after filing RCE under §1.114, whichever occurs last)		
[X]	under 37 CFR 1.97(c) together with either:		•
	[] a Statement under 37 CFR 1.97(e),	as checked below, or	
	[X] the \$180.00 fee under 37 CFR 1.17 (After the 37 CFR 1.97(b) time period, but or other action which closes prosecution, v	t before final action or notice of	of allowance,
[]	under 37 CFR 1.97(d) together with:		•

(Filed after final action or notice of allowance, whichever occurs first, but before

a Statement under 37 CFR 1.97(e), as checked below, and

the \$180.00 fee set forth in 37 CFR 1.17(p).

payment of the issue fee)

[]

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Applicant(s): Soo-geun Lee, et al.

Serial No.:

[]

[]

abstract.

10/081,661

		Statement Under 37 1.97(e)	
	[] Each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign pater office in a counterpart foreign application not more than three mont prior to the filing of this Information Disclosure Statement.		
	[]	No item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, after making reasonable inquiry, was known to any individual designated in 37 CFR 1.56(c) more than three months prior to the filing of this Information Disclosure Statement.	
Enclos	sed herewith is	form PTO-1449:	
[X]	Copies of cited references are enclosed.		
[]	Copies of cited references are enclosed except those entered in prior application, U.S. Serial No, and references that are not required to be submitted under 37 CFR 1.98.		
[]	The listed references were cited in a counterpart foreign application.		
Concis	se Explanation	Requirement (non-English references):	
[]	[] The "concise explanation" requirement under 36 CFR 1.98(a)(3)(i) for reference XX is satisfied by:		
	[] the exp	planation provided on the attached sheet.	
•	[] the exp	planation provided in the Specification.	

It is requested the information disclosed herein be made of record in this application.

Applicant(s): Soo-geun Lee, et al.

Serial No.: 10/081,661

Method of payment:

[X] Enclosed is a check in the amount of \$180.00

[] Please charge Deposit Account of 50-1798 in the amount of ______.

[] Two duplicate copies of this Statement are enclosed.

[X] Please charge any deficiency in fees and credit any overpayment to Deposit Account No. 50-1798.

Respectfully submitted,

Registration Number 36,610 Attorney for Applicants

Facsimile: (617) 742-7774

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	Sheet	1	of	1
onal)	Application Number			

Group Art Unit

\$\u00e4bst. Form PTO-1449

NFORMATION DISCLOSURE CITATION - IN AN APPLICATION

(Use several sheets if necessary)

Docket Number (Optional)	Application Number			
SAM-0313	10/081,661			
Applicant, Soo-geun Lee, et al.				

Filing Date

2812 2-22-02 U. S. Patent Documents FILING DATE
IF APPROPRIATE EXAMINER INITIAL DOCUMENT NAME CLASS SUBCLASS DATE AA AB Matsuki, et al. 257 642 4/25/02 6,559,520 5/6/03 Matsuki, et al. 780 4/6/01 AC 438 6,514,880 2/4/03 AD 438 789 3/28/01 6,455,445 9/24/02 Matsuki AE 438 790 10/18/00 6,432,846 8/13/02 Matsuki 438 790 10/18/00 AF 6,410,463 6/25/02 Matsuki AG 438 790 6/7/99 6,383,955 5/7/02 Matsuki, et al. 778 6/7/99 AH 6,352,945 Matsuki, et al. 438 3/5/02 12/17/97 689 ΑI 5/2/00 438 6,057,239 Wang, et al. AJ H01L 21/302 3/22/00 01/0046778 11/29/01 Wang, et al. ΑK FOREIGN PATENT DOCUMENTS Translation DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS YES AL AM AN AO AP AQ OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Jiang, P., et al., "Trench Etch Processes for Dual Damascene Patterning of Low-k AR Dielectrics, J. Vac. Sci. Technology, A 19(4), Jul/Aug 2001, p. 1388-1391. AS AT DATE CONSIDERED **EXAMINER**

through citation if not in conformance and not considered. Include copy with next communication to applicant. L&K Subst. PTO-1449 (1-94)

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line